

<Hybrid-SiC Modules>

CMH300DX-24NFH

HIGH POWER SWITCHING USE **INSULATED TYPE**



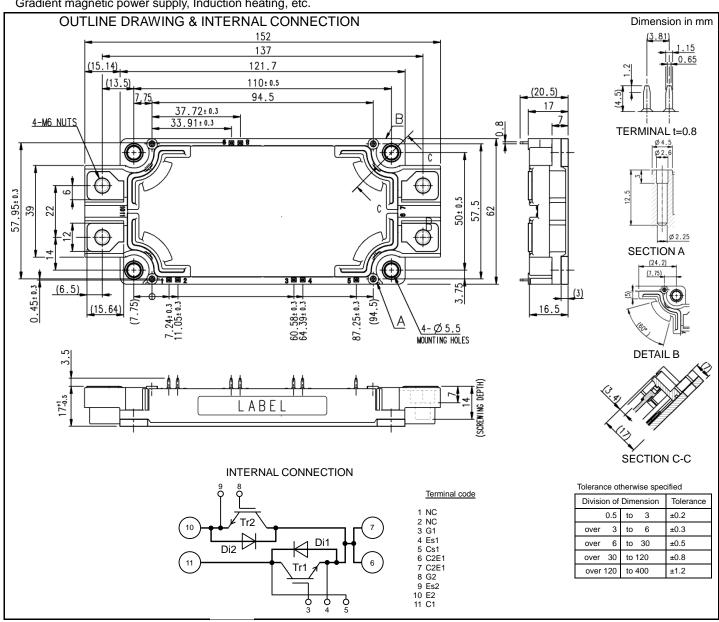
Collector current I_C 300A Collector-emitter voltage V_{CES} 1 2 0 0 V Maximum junction temperature T_{jmax}

- •Silicon IGBT + Silicon Carbide Schottky Barrier Diode
- •Flat base Type
- •Copper base plate
- •RoHS Directive compliant
- •Recognized under UL1557, File E323585

APPLICATION

High frequency switching use(30kHz to 60kHz)

Gradient magnetic power supply, Induction heating, etc.



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INSULATED TYPE

MAXIMUM RATINGS (T_j=25 °C, unless otherwise specified, per 1/2 module)

| Symbol | Item | Conditions | Rating | Unit |
|--------------------------|---------------------------|-------------------------------------------------|--------------------|------|
| V _{CES} | Collector-emitter voltage | G-E short-circuited | 1200 | V |
| V _{GES} | Gate-emitter voltage | C-E short-circuited | ± 20 | V |
| Ic | Collector ourrent | DC, T _C =25 °C (Note2, 4) | 300 | ^ |
| I _{CRM} | Collector current | Pulse, Repetitive (Note3) | 600 | Α |
| P _{tot} | Total power dissipation | T _C =25 °C (Note2, 4) | 1890 | W |
| I _E (Note1) | Emitter current | DC, T _C =25 °C (Note2, 4) | 300 | ^ |
| I _{ERM} (Note1) | Emilier current | Pulse, Repetitive (Note3) | 600 | Α |
| Visol | Isolation voltage | Terminals to base plate, RMS, f=60 Hz, AC 1 min | 4000 | V |
| T _j | Junction temperature | - | -40 ~ + 150 | °C |
| T _{stg} | Storage temperature | - | -40 ~ +125 | |

ELECTRICAL CHARACTERISTICS (T_j =25 °C, unless otherwise specified, per 1/2 module)

| Symbol | Item | Conditions | | Limits | | | Unit |
|--------------------------|---------------------------------------------------------|------------------------------------------------------------------------------------------|--------------------------------------------------------------------------|--------|------|------|------|
| Symbol | Rem Conditions | | | Min. | Тур. | Max. | Unit |
| I _{CES} | Collector-emitter cut-off current | V _{CE} =V _{CES} , G-E short-circuited | | - | - | 11.0 | mA |
| I _{GES} | Gate-emitter leakage current | V _{GE} =V _{GES} , C-E short-circuited | | - | - | 1.0 | μA |
| $V_{GE(th)}$ | Gate-emitter threshold voltage | I _C =30 mA, V _{CE} =10 V | | 4.5 | 6.0 | 7.5 | V |
| | V _{CEsat} Collector-emitter saturation voltage | I _C =300 A, V _{GE} =15 V (Note5) | T _j =25 °C | - | 5.0 | 6.5 | V |
| V CEsat | | Refer to the figure of test circuit | T _j =125 °C | - | 5.0 | - | V |
| Cies | Input capacitance | V _{CE} =10 V, G-E short-circuited | | - | - | 47 | |
| Coes | Output capacitance | | | - | - | 5.6 | nF |
| Cres | Reverse transfer capacitance | 1 | | | - | 1.1 | |
| Q _G | Gate charge | V _{CC} =600 V, I _C =300 A, V _{GE} =15 V | | - | 1360 | - | nC |
| t _{d(on)} | Turn-on delay time | - V _{CC} =600 V, I _C =300 A, V _{GE} =±15 V, | | - | - | 300 | |
| tr | Rise time | | | - | - | 80 | |
| t _{d(off)} | Turn-off delay time | R _G =1.0 Ω, Inductive load | | - | - | 500 | ns |
| t _f | Fall time | | | - | - | 150 | |
| V=o (Note1) | Fraitten cellecten veltere | I _E =300 A, G-E short-circuited (Note5) | I _E =300 A, G-E short-circuited (Note5) T _j =25 °C | | 2.2 | 2.7 | |
| V _{EC} (Note1) | Emitter-collector voltage | Refer to the figure of test circuit | T _j =125 °C | - | 2.9 | - | V |
| Q _C (Note1) | Total capacitive charge | V_{CC} =600 V, I_{E} =300 A, V_{GE} =±15 V, R_{G} =1.0 Ω , Inductive load | | - | 2.8 | - | μC |
| Eon | Turn-on switching energy per pulse | V _{CC} =600 V, I _C /I _E =300 A, | | - | 5.0 | - | 1 |
| E _{off} | Turn-off switching energy per pulse | V_{GE} =±15 V, R_{G} =1.0 Ω , | | - | 10.0 | - | mJ |
| E _{rec} (Note1) | Reverse energy per pulse | T _j =125 °C, Inductive load | | - | 1.0 | - | mJ |
| r _g | Internal gate resistance | Per switch | | - | 0.8 | - | Ω |

THERMAL RESISTANCE CHARACTERISTICS (per 1/2 module)

| Symbol | Itam | Conditions | Limits | | | Unit |
|----------------|----------------------------|------------------------------------------------------|--------|-------|-------|-------|
| | ltem ltem | Conditions | Min. | Тур. | Max. | Offic |
| $R_{th(j-c)Q}$ | Thermal resistance | Junction to case (Note4) | - | - | 0.066 | K/W |
| $R_{th(j-c)D}$ | Theimai resistance | Junction to case (Note4) | - | - | 0.245 | r\/vv |
| $R_{th(c-s)}$ | Contact thermal resistance | Case to heat sink, Thermal grease applied (Note4, 6) | - | 0.015 | - | K/W |

Caution; No short-circuit capability is designed.

HIGH POWER SWITCHING USE

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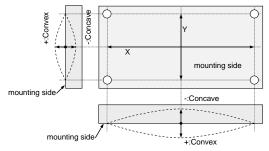
MECHANICAL CHARACTERISTICS

| Symbol | Itama | Item Conditions | | Limits | | | Unit |
|----------------|------------------------|-----------------------------|------------|--------|------|------|------|
| | Item | Conditions | Conditions | | Тур. | Max. | Unit |
| M _t | Mounting torque | Main terminals | M 6 screw | 3.5 | 4.0 | 4.5 | N⋅m |
| Ms | Mounting torque | Mounting to heat sink | M 5 screw | 2.5 | 3.0 | 3.5 | N⋅m |
| ds | Creepage distance | Terminal to terminal | | 17.0 | - | - | - mm |
| | | Terminal to base plate | | 18.5 | - | - | |
| da | Clearance | Terminal to terminal | | 10.0 | - | - | mm |
| | Clearance | Terminal to base plate | | 16.3 | - | - | mm |
| m | mass | - | | - | 350 | - | g |
| ec | Flatness of base plate | On the centerline X (Note7) | | 0 | - | 100 | um |
| | Flatness of base plate | On the centerline Y (Note7) | | 0 | - | 100 | μm |

^{*:} This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (DIODE).

- 2. Junction temperature (T_j) should not increase beyond T_{jmax} rating.
- 3. Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed $T_{j\,m\,a\,x}$ rating.
- 4. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
- 5. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- $6. \ \ \, B_{(25/50)} = In(\frac{R_{25}}{R_{50}}) / (\frac{1}{T_{25}} \frac{1}{T_{50}}) \\ \qquad \qquad R_{25} : resistance \ at \ absolute \ temperature \ T_{25} \ [K]; \ T_{25} = 25 \ [°C] + 273.15 = 298.15 \ [K] \\ \qquad \qquad R_{50} : resistance \ at \ absolute \ temperature \ T_{50} \ [K]; \ T_{50} = 50 \ [°C] + 273.15 = 323.15 \ [K]$
- 7. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K).
- 8. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.

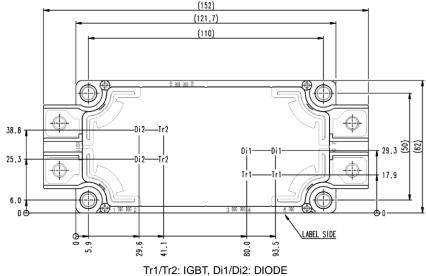


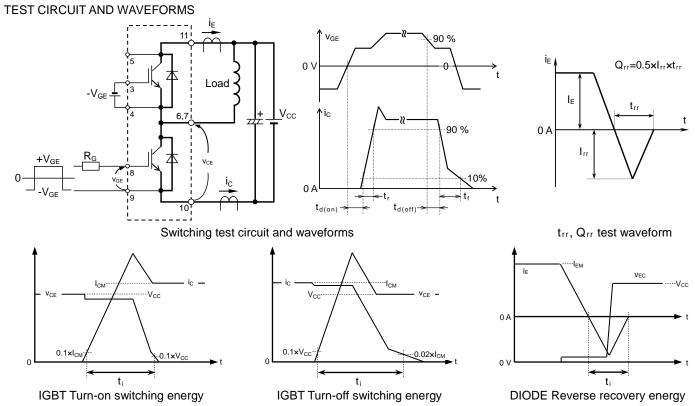
RECOMMENDED OPERATING CONDITIONS

| Symbol | ltom | Conditions | Limits | | | Unit |
|-----------------|-------------------------------|----------------------------------------|--------|------|------|-------|
| | ltem ltem | Conditions | Min. | Тур. | Max. | Offic |
| V _{cc} | (DC) Supply voltage | Applied across C1-E2 terminals | - | 600 | 800 | V |
| V_{GEon} | Gate (-emitter drive) voltage | Applied across G1-Es1/G2-Es2 terminals | 13.5 | 15.0 | 16.5 | V |
| R_G | External gate resistance | Per switch | 1.0 | - | 10 | Ω |

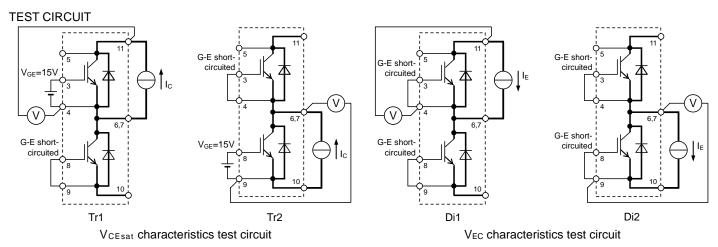
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm





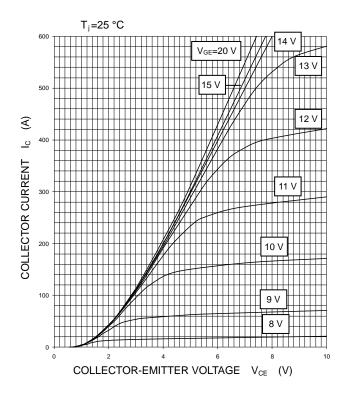
Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)



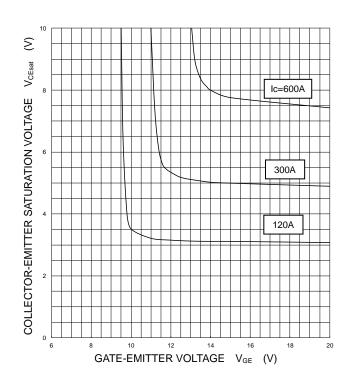
HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

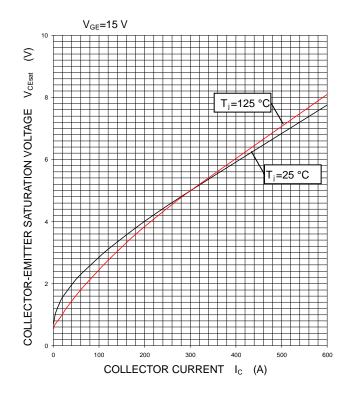
OUTPUT CHARACTERISTICS (TYPICAL)



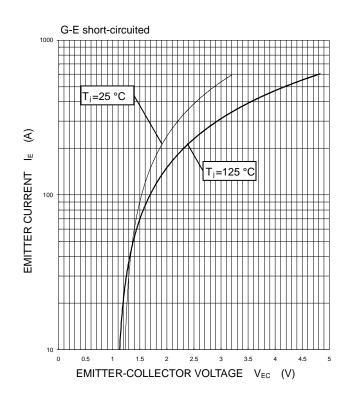
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

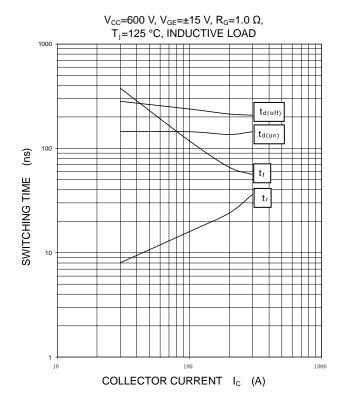


HIGH POWER SWITCHING USE

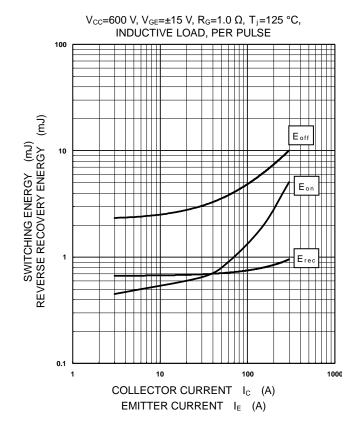
INSULATED TYPE

PERFORMANCE CURVES

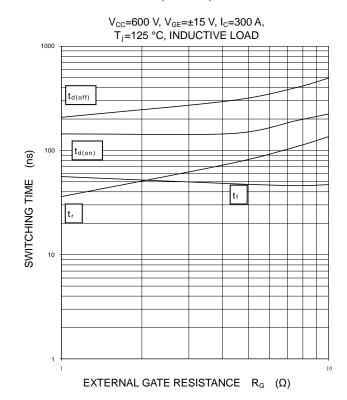
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



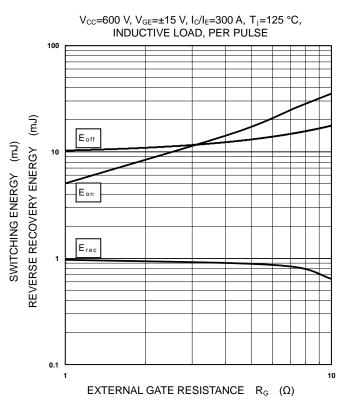
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



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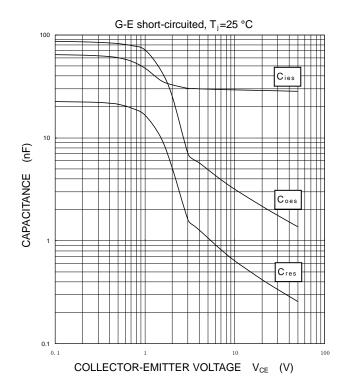


HIGH POWER SWITCHING USE

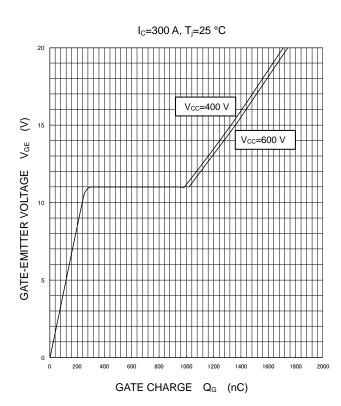
INSULATED TYPE

PERFORMANCE CURVES

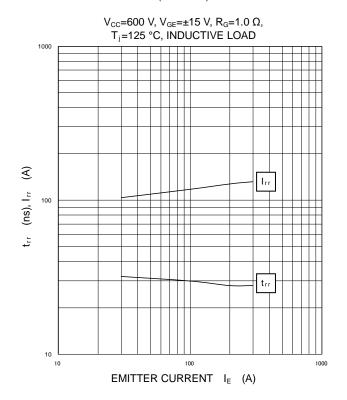
CAPACITANCE CHARACTERISTICS (TYPICAL)



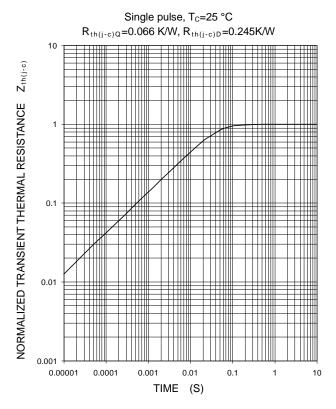
GATE CHARGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTIC S (MAXIMUM)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

HIGH POWER SWITCHING USE INSULATED TYPE

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